Se	arcn	NOTE	25

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,307	KIM ET AL.	
Examiner	Art Unit	
Lucy P. Chien	2871	

	SEAR	CHED	:
Class	Subclass	Date	Examiner
,			· _
			. <u>.</u>
	\.		
-			

INT	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner
	()		
7			
			1

(INCLUDING SEAR		1
	DATE	EXMR
Updated search in EAST	11/30/2006	LC
<u> </u>		
		
,		